

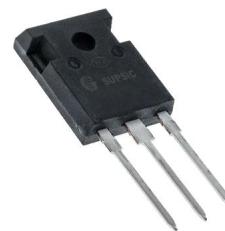
Features

- High blocking voltage with low on-resistance
- High speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant



Benefits

- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency
- Easy to parallel and simple to drive
- Enable new hard switching PFC topologies (Totem-Pole)



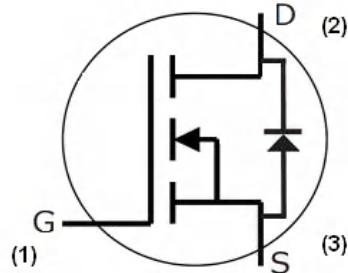
TO-247-3

Applications

- EV charging
- Solar PV Inverters
- UPS
- SMPS
- DC/DC converters

Part Number	Package	Marking
GC3M0015065D	TO-247-3	GC3M0015065

Package



Maximum Ratings ($T_c=25^\circ\text{C}$, unless otherwise specified)

Symbol	Parameter	Value	Unit	Note
$V_{DS\max}$	Drain - Source Voltage	650	V	
$V_{GS\max}$	Gate - Source voltage	-8/+19	V	Note 1
I_D	Continuous Drain Current, $V_{GS} = 15 \text{ V}$, $T_c = 25^\circ\text{C}$	120	A	Fig. 19 Note 2
	Continuous Drain Current, $V_{GS} = 15 \text{ V}$, $T_c = 100^\circ\text{C}$	96		
$I_{D(\text{pulse})}$	Pulsed Drain Current, Pulse width t_p limited by $T_{j\max}$	418	A	
P_D	Power Dissipation, $T_c=25^\circ\text{C}$, $T_j = 175^\circ\text{C}$	416	W	Fig. 20
T_J, T_{stg}	Operating Junction and Storage Temperature	-40 to +175	°C	
T_L	Solder Temperature, 1.6mm (0.063") from case for 10s	260	°C	
M_d	Mounting Torque, (M3 or 6-32 screw)	1 8.8	Nm lbf-in	

Note (1): Recommended turn off / turn on gate voltage V_{GS} - 4V...0V / +15V

Note (2): Package limited to 120 A

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note		
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$			
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.8	2.3	3.6	V	$V_{DS} = V_{GS}, I_D = 15.5 \text{ mA}$	Fig. 11		
			1.9		V	$V_{DS} = V_{GS}, I_D = 15.5 \text{ mA}, T_J = 175^\circ\text{C}$			
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$			
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$			
$R_{DS(\text{on})}$	Drain-Source On-State Resistance	10.5	15	21	$\text{m}\Omega$	$V_{GS} = 15 \text{ V}, I_D = 55.8 \text{ A}$	Fig. 4, 5,6		
			20			$V_{GS} = 15 \text{ V}, I_D = 55.8 \text{ A}, T_J = 175^\circ\text{C}$			
g_{fs}	Transconductance		42		S	$V_{DS} = 20 \text{ V}, I_{DS} = 55.8 \text{ A}$	Fig. 7		
			40			$V_{DS} = 20 \text{ V}, I_{DS} = 55.8 \text{ A}, T_J = 175^\circ\text{C}$			
C_{iss}	Input Capacitance		5011		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 400 \text{ V}$ $f = 100 \text{ KHz}$ $V_{AC} = 25 \text{ mV}$	Fig. 17, 18		
C_{oss}	Output Capacitance		289						
C_{rss}	Reverse Transfer Capacitance		31						
$C_{o(er)}$	Effective Output Capacitance (Energy Related)		357						
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		516						
E_{oss}	C_{oss} Stored Energy		29		μJ	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 55.8 \text{ A},$ $R_{G(\text{ext})} = 5 \Omega, L = 57.6 \mu\text{H}, T_J = 175^\circ\text{C}$ FWD = Internal Body Diode of MOSFET	Fig. 16		
E_{ON}	Turn-On Switching Energy (Body Diode)		1500		μJ				
E_{OFF}	Turn Off Switching Energy (Body Diode)		700						
E_{ON}	Turn-On Switching Energy (External Diode)		1200		μJ	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_D = 55.8 \text{ A},$ $R_{G(\text{ext})} = 5 \Omega, L = 57.6 \mu\text{H}, T_J = 175^\circ\text{C}$ FWD = External SiC DIODE	Fig. 25		
E_{OFF}	Turn Off Switching Energy (External Diode)		1000						
$t_{d(on)}$	Turn-On Delay Time		22		ns	$V_{DD} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 55.8 \text{ A}, R_{G(\text{ext})} = 5 \Omega, L = 57.6 \mu\text{H}$ Timing relative to V_{DS} Inductive load	Fig. 26		
t_r	Rise Time		125						
$t_{d(off)}$	Turn-Off Delay Time		58						
t_f	Fall Time		25						
$R_{G(int)}$	Internal Gate Resistance		1.5		Ω	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$			
Q_{gs}	Gate to Source Charge		54		nC	$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 55.8 \text{ A}$ Per IEC60747-8-4 pg 21	Fig. 12		
Q_{gd}	Gate to Drain Charge		62						
Q_g	Total Gate Charge		188						

Note (3): $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{oss} while V_{ds} is rising from 0 to 400V
 $C_{o(tr)}$, a lumped capacitance that gives same charging time as C_{oss} while V_{ds} is rising from 0 to 400V

Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.7		V	$V_{GS} = -4 \text{ V}, I_{SD} = 27.9 \text{ A}, T_j = 25^\circ\text{C}$	Fig. 8, 9, 10'
		4.2		V	$V_{GS} = -4 \text{ V}, I_{SD} = 27.9 \text{ A}, T_j = 175^\circ\text{C}$	
I_S	Continuous Diode Forward Current		79	A	$V_{GS} = -4 \text{ V}, T_c = 25^\circ\text{C}$	
$I_{S,pulse}$	Diode pulse Current		418	A	$V_{GS} = -4 \text{ V}, \text{pulse width } t_p \text{ limited by } T_{jmax}$	
t_{rr}	Reverse Recovery time	85		ns	$V_{GS} = -4 \text{ V}, I_{SD} = 55.8 \text{ A}, V_R = 400 \text{ V}$ $\text{dif/dt} = 1500 \text{ A}/\mu\text{s}, T_j = 175^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	667		nC		
I_{rrm}	Peak Reverse Recovery Current	17		A		
t_{rr}	Reverse Recovery time	74		ns		
Q_{rr}	Reverse Recovery Charge	562		nC	$V_{GS} = -4 \text{ V}, I_{SD} = 55.8 \text{ A}, V_R = 400 \text{ V}$ $\text{dif/dt} = 1000 \text{ A}/\mu\text{s}, T_j = 175^\circ\text{C}$	
I_{rrm}	Peak Reverse Recovery Current	14		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{θJC}$	Thermal Resistance from Junction to Case	0.35	°C/W		Fig. 21
$R_{θJA}$	Thermal Resistance From Junction to Ambient	40			

Typical Performance

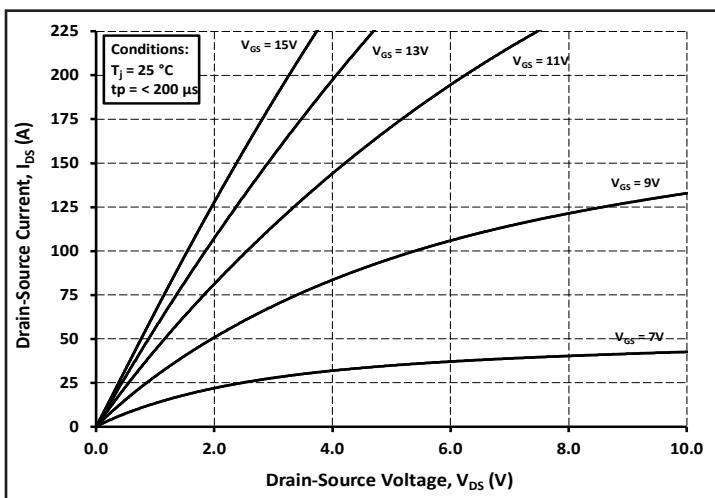
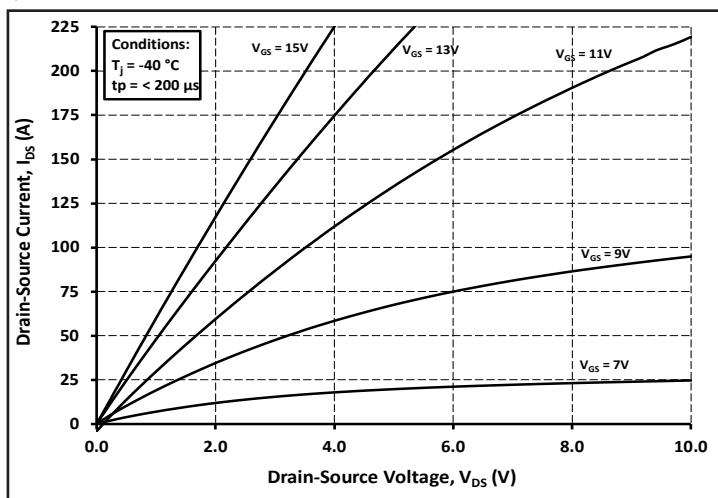


Figure 1. Output Characteristics $T_j = -40 \text{ } ^\circ\text{C}$

Figure 2. Output Characteristics $T_j = 25 \text{ } ^\circ\text{C}$

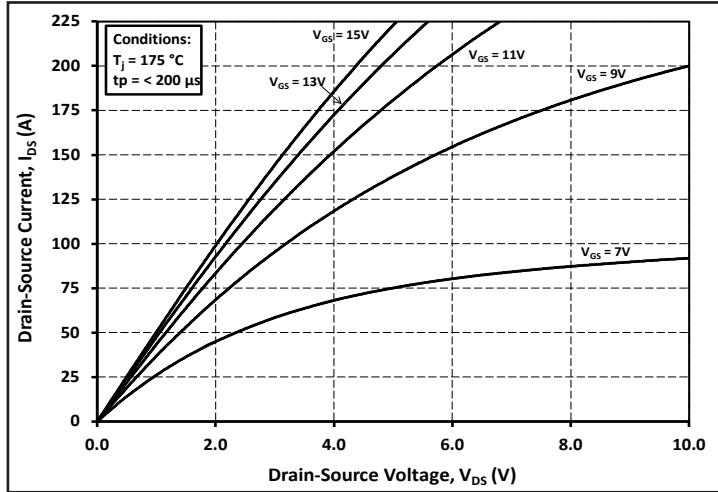


Figure 3. Output Characteristics $T_j = 175 \text{ } ^\circ\text{C}$

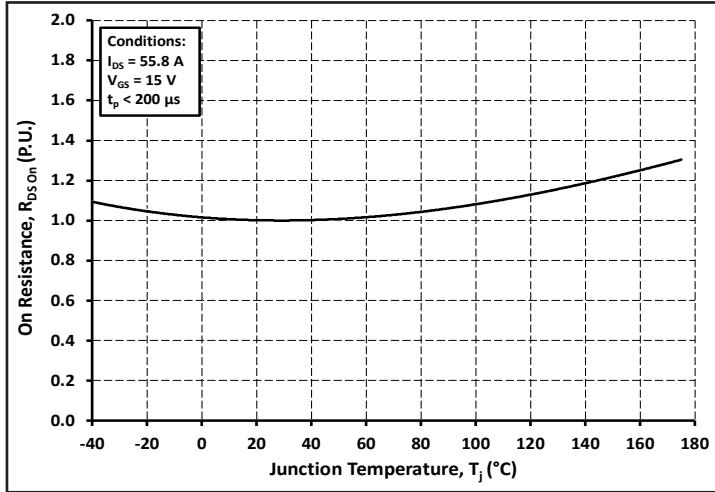


Figure 4. Normalized On-Resistance vs. Temperature

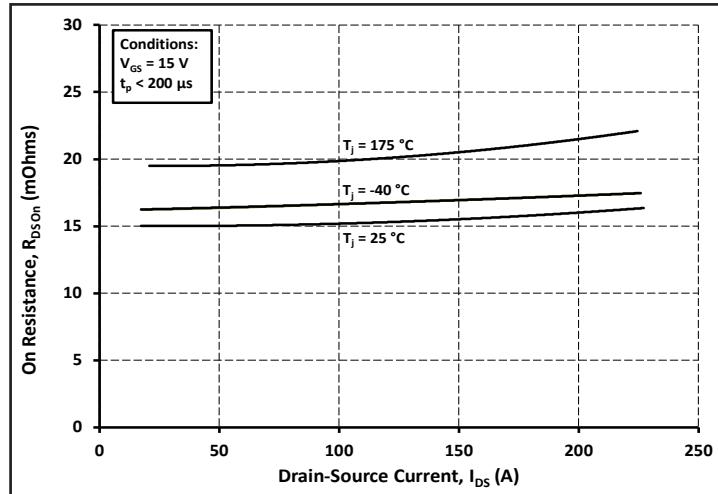


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

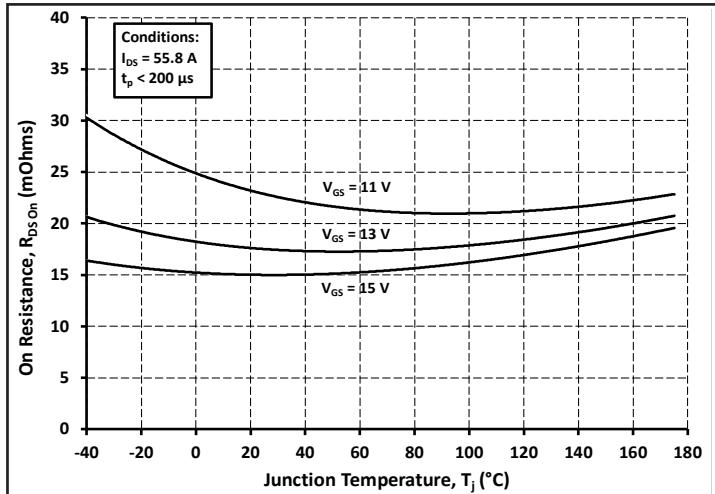


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

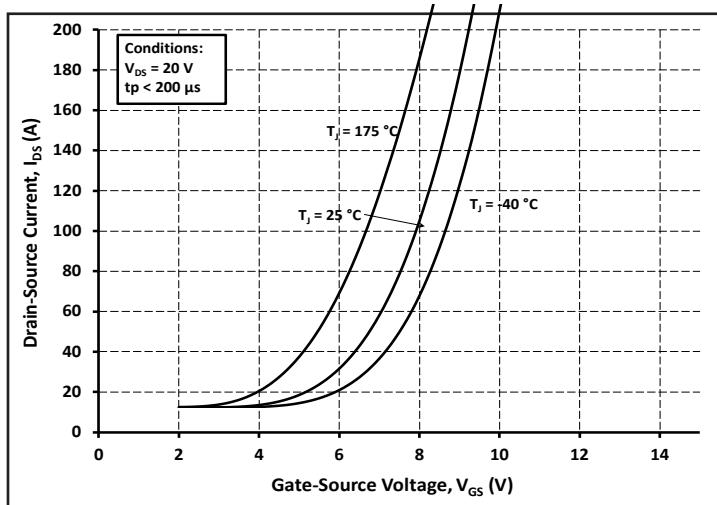


Figure 7. Transfer Characteristic for Various Junction Temperatures

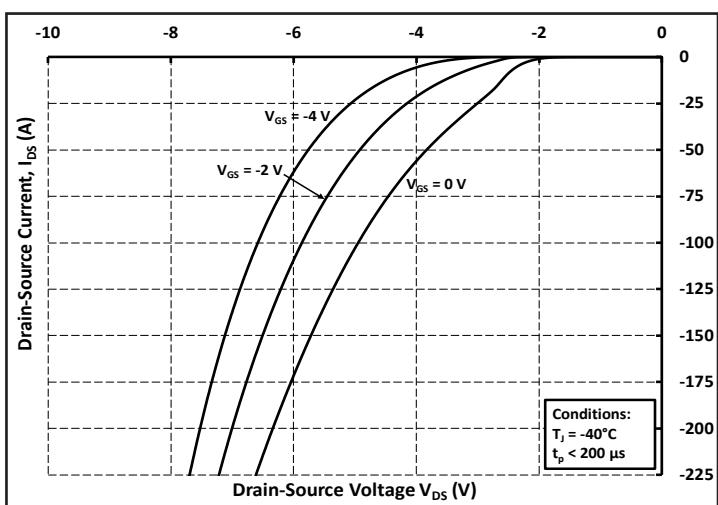


Figure 8. Body Diode Characteristic at -40°C

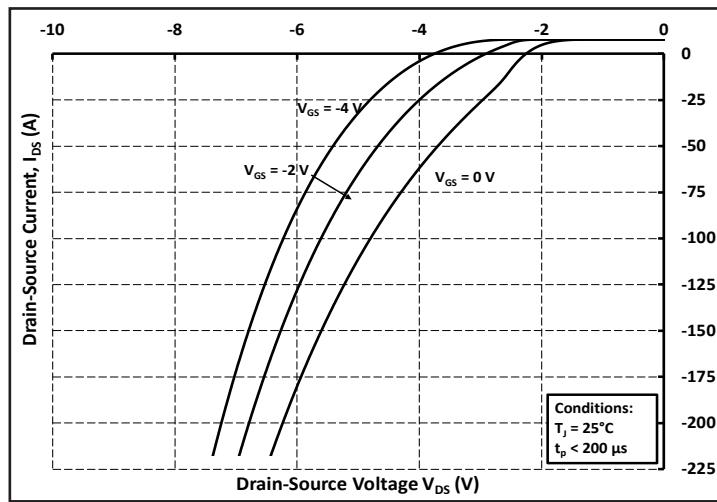


Figure 9. Body Diode Characteristic at 25°C

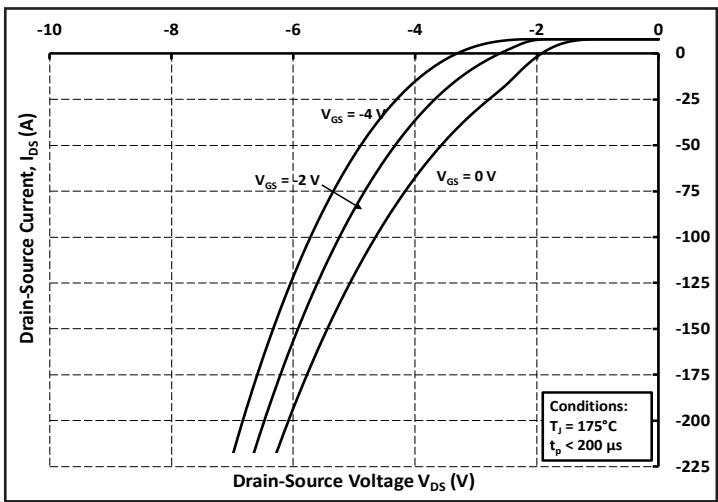


Figure 10. Body Diode Characteristic at 175°C

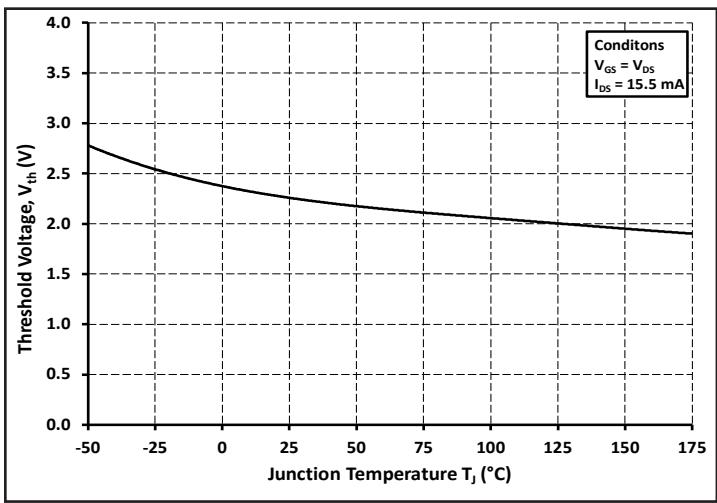


Figure 11. Threshold Voltage vs. Temperature

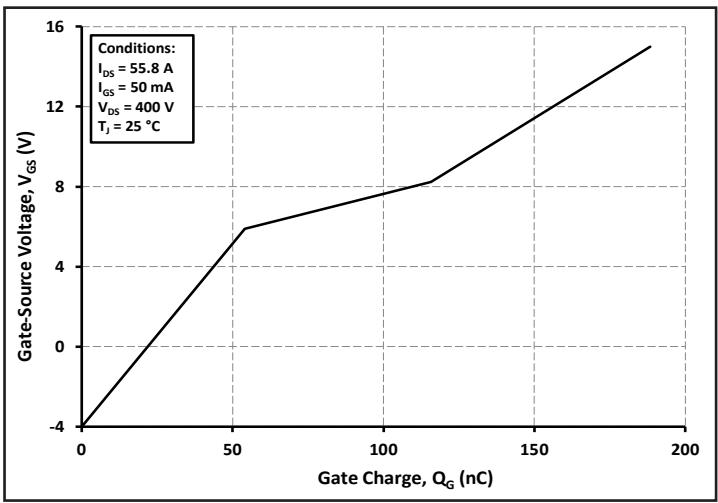


Figure 12. Gate Charge Characteristics

Typical Performance

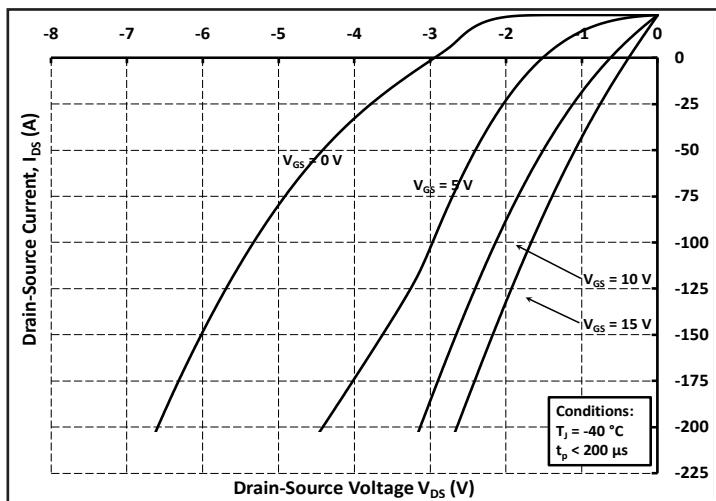


Figure 13. 3rd Quadrant Characteristic at -40°C

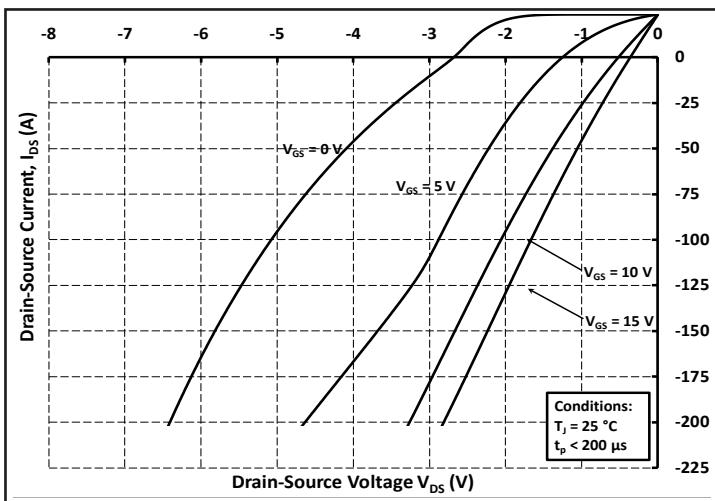


Figure 14. 3rd Quadrant Characteristic at 25°C

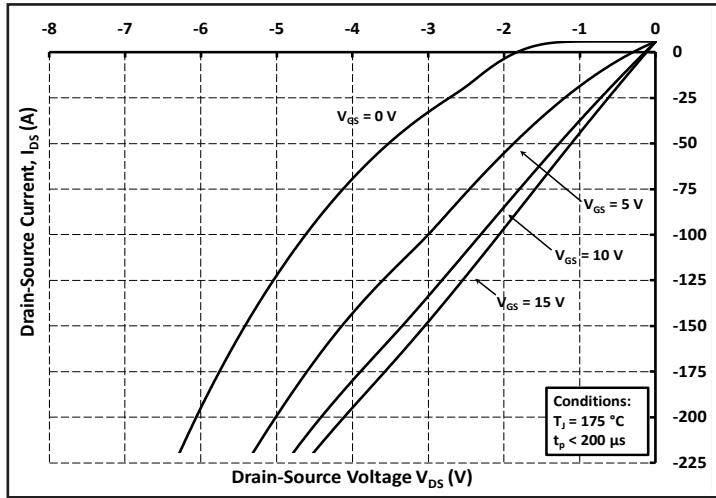


Figure 15. 3rd Quadrant Characteristic at 175°C

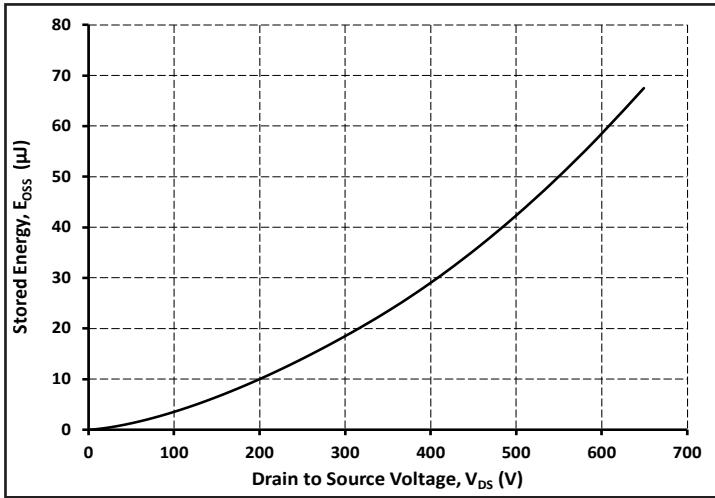


Figure 16. Output Capacitor Stored Energy

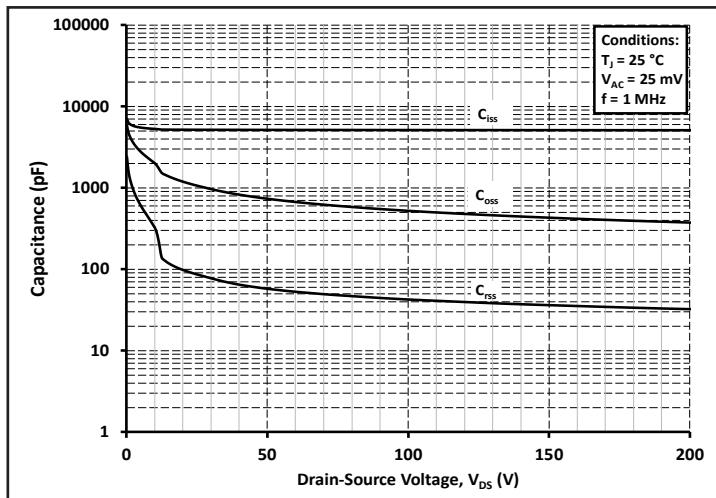


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

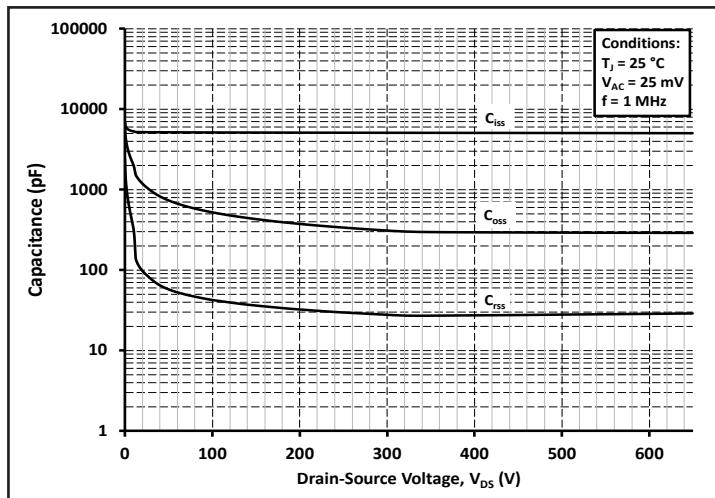


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)

Typical Performance

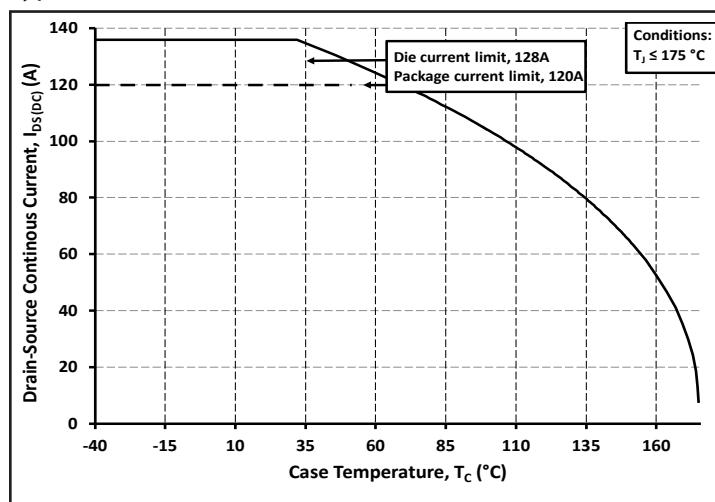


Figure 19. Continuous Drain Current Derating vs.
Case Temperature

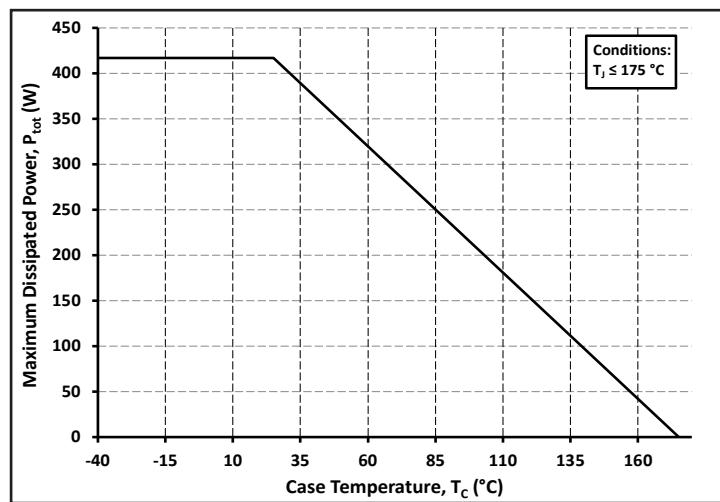


Figure 20. Maximum Power Dissipation Derating vs.
Case Temperature

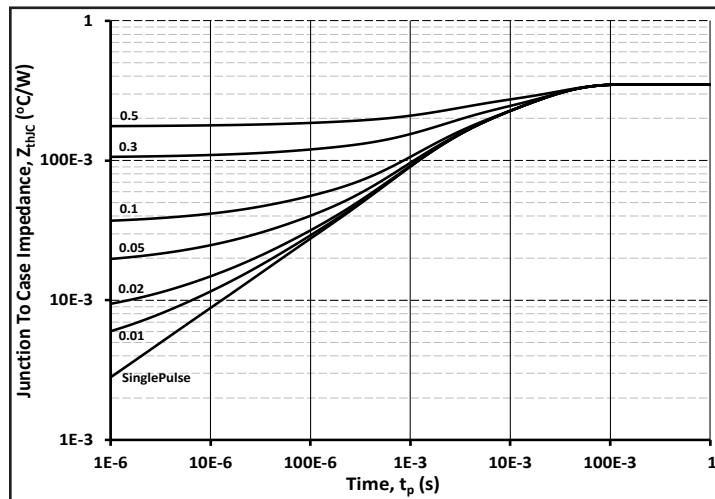


Figure 21. Transient Thermal Impedance
(Junction - Case)

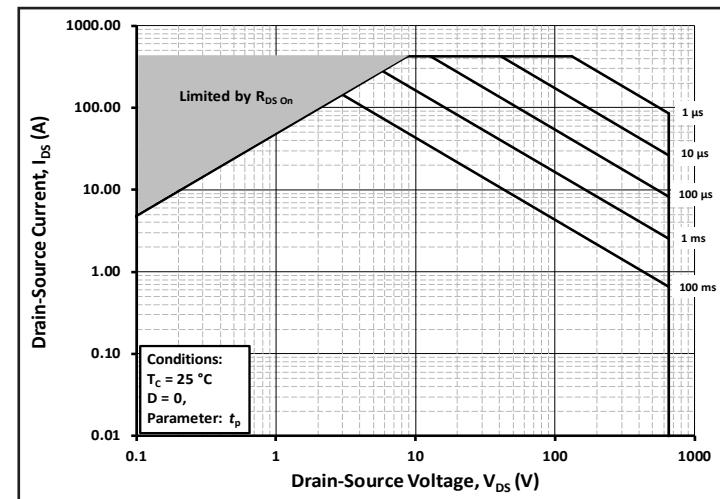


Figure 22. Safe Operating Area

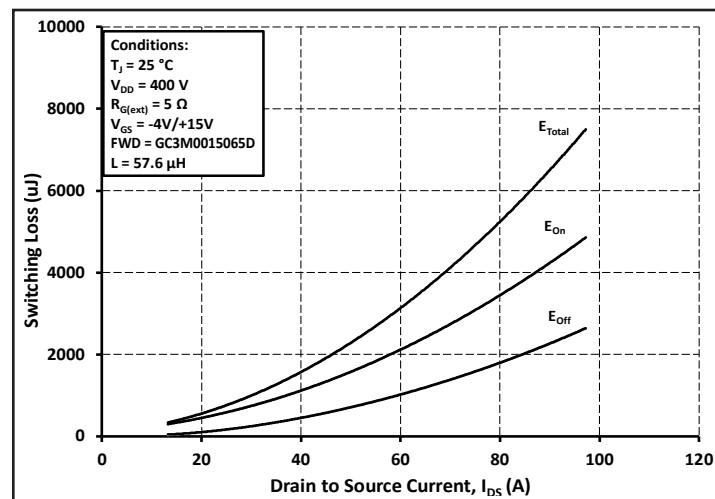


Figure 23. Clamped Inductive Switching Energy vs.
Drain Current (V_{DD} = 400V)

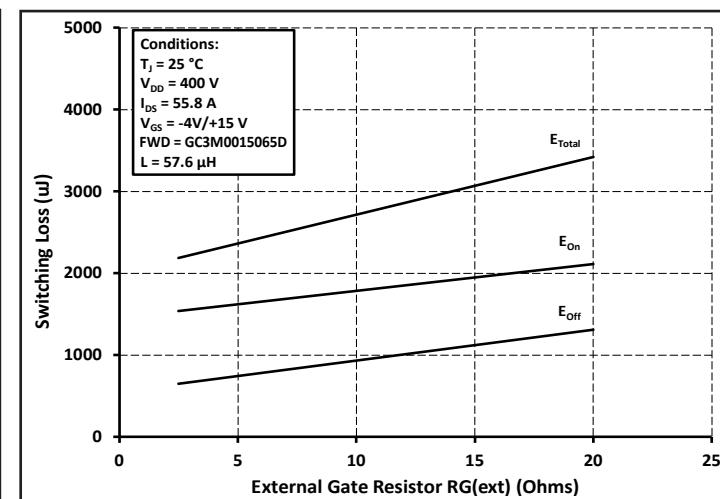


Figure 24. Clamped Inductive Switching Energy vs. R_{G(ext)}

Typical Performance

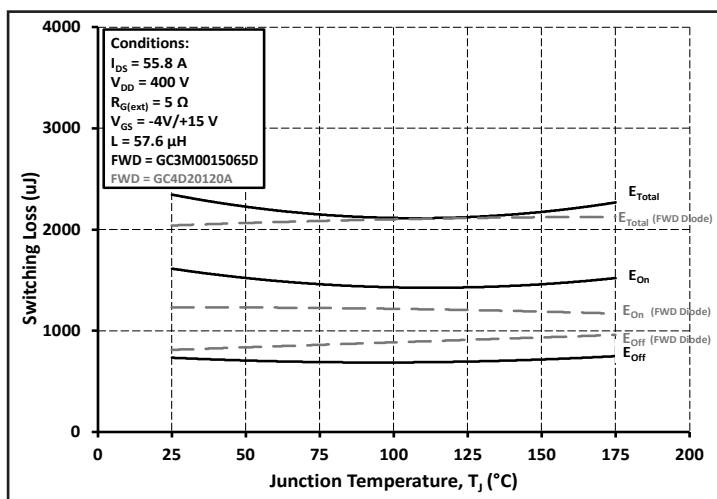


Figure 25. Clamped Inductive Switching Energy vs.
Temperature

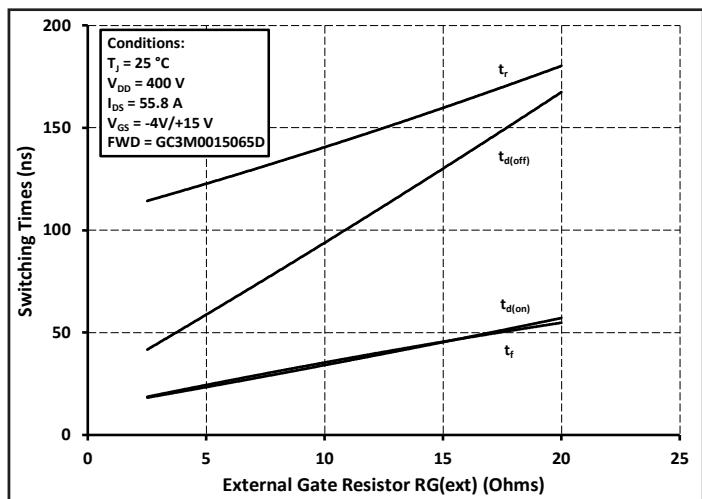


Figure 26. Switching Times vs. $R_{G(\text{ext})}$

Test Circuit Schematic

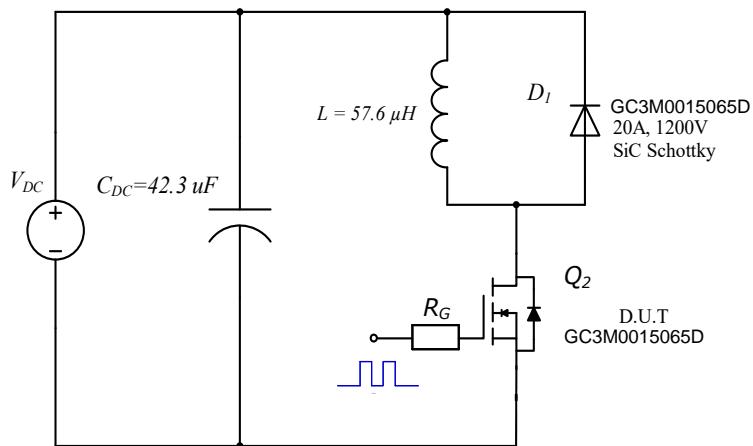


Figure 27. Clamped Inductive Switching
Waveform Test Circuit

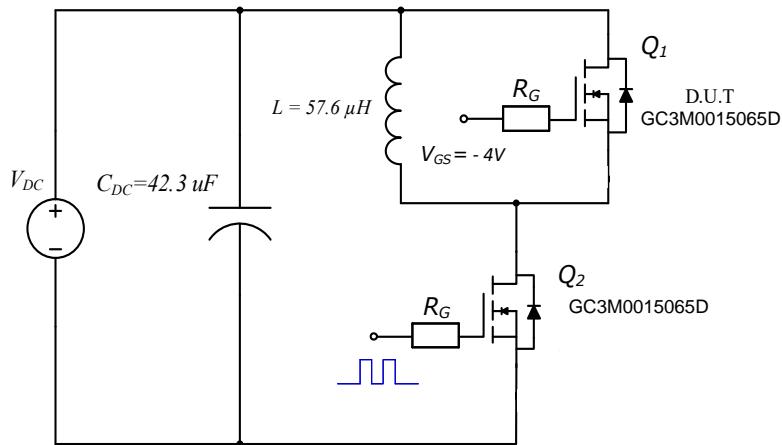
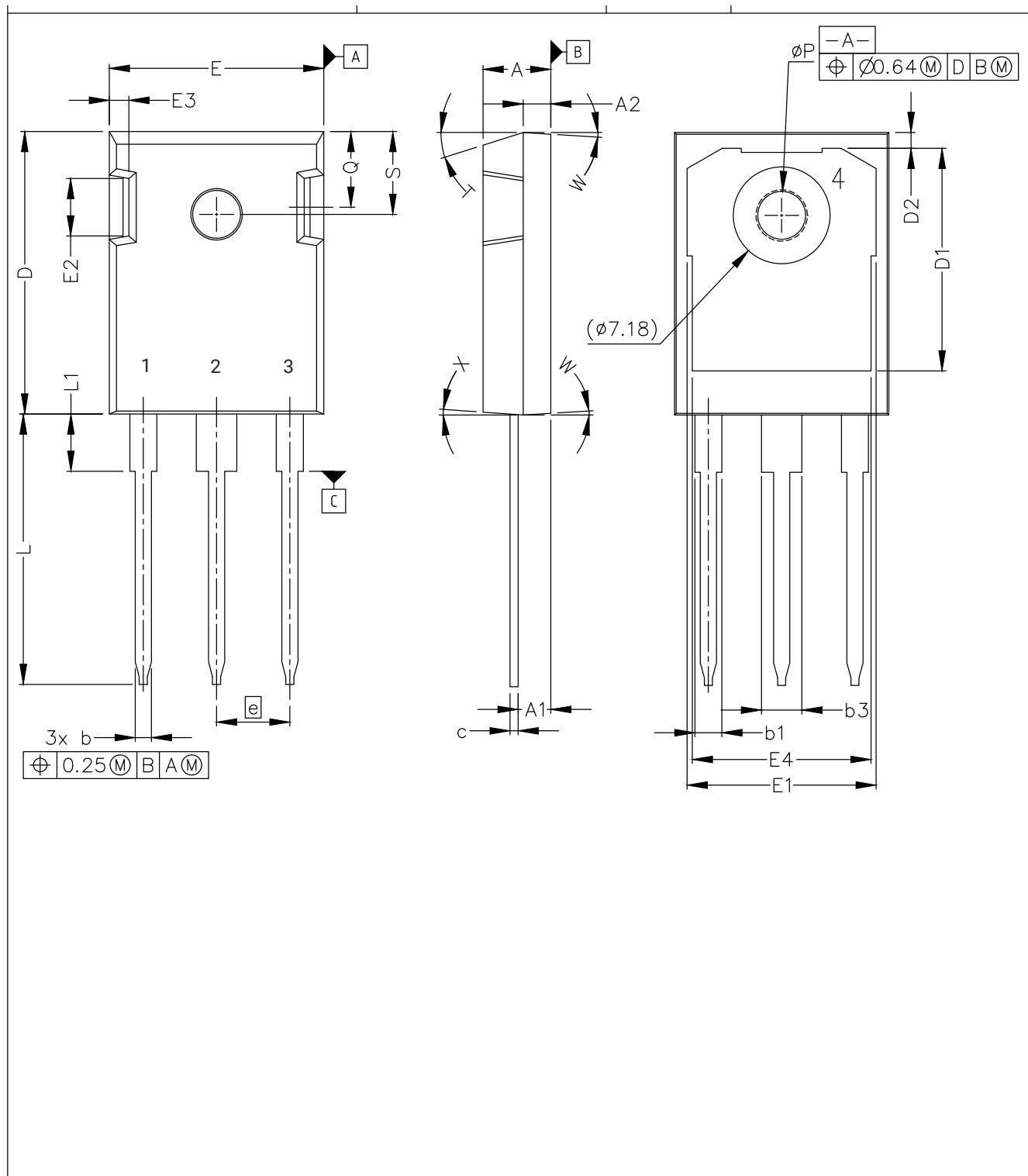


Figure 28. Body Diode Recovery Test Circuit

Package Dimensions

Package TO-247-3



Package Dimensions

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SYM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	.190	.205
A1	2.29	2.54	.090	.100
A2	1.91	2.16	.075	.085
b	1.07	1.33	.042	.052
b1	1.91	2.41	.075	.095
b3	2.87	3.38	.113	.133
c	0.55	0.68	.022	.027
D	20.80	21.10	.819	.831
D1	16.25	17.65	.640	.695
D2	0.95	1.25	.037	.049
E	15.75	16.13	.620	.635
E1	13.10	14.15	.516	.557
E2	3.68	5.10	.145	.201
E3	1.00	1.90	.039	.075
E4	12.38	13.43	.487	.529
e	5.44 BSC		.214 BSC	
N	3		3	
L	19.81	20.32	.780	.800
L1	4.10	4.40	.161	.173
ΦP	3.51	3.65	.138	.144
Q	5.49	6.00	.216	.236
S	6.04	6.30	.238	.248
T	17.5° REF.			
W	3.5° REF.			
X	4° REF.			

Recommended Solder Pad Layout

TO-247-3